

K2590-VB Datasheet N-Channel 200 V (D-S) MOSFET

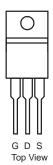
| PRODUCT SUMMARY | | | | | |
|---------------------|---------------------------------|--------------------|--|--|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) | | | |
| 200 | 0.270 at V _{GS} = 10 V | 10 | | | |

FEATURES

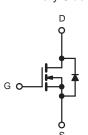
- DT-Trench Power MOSFET
- 175 °C Junction Temperature
- PWM Optimized
- 100 % R_g Tested
 Compliant to RoHS Directive 2002/95/EC







APPLICATIONS Primary Side Switch



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted) | | | | | | |
|--|-------------------------|-----------------------------------|------------------|----|--|--|
| Parameter | Symbol | Limit | Unit | | | |
| Drain-Source Voltage | V _{DS} | 200 | | | | |
| Gate-Source Voltage | | | ± 20 | V | | |
| Continuous Danie Comment /T., 475 900h | T _C = 25 °C | - I _D | 10 | | | |
| Continuous Drain Current (T _J = 175 °C) ^b | T _C = 125 °C | | 6 | | | |
| Pulsed Drain Current | | I _{DM} | 38 | А | | |
| Continuous Source Current (Diode Conduction) | I _S | 12 | | | | |
| Avalanche Current | I _{AS} | 10 | | | | |
| Single Pulse Avalanche Energy | L = 0.1 mH | E _{AS} | 18 | mJ | | |
| Maximum Power Dissipation | T _C = 25 °C | PD | 121 ^b | W | | |
| Maximum Fower Dissipation | T _A = 25 °C | ' D | 2 ^a | VV | | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to 175 | °C | | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|----------------------------------|--------------|---------------------|---------|---------|------|--|--|
| Parameter | | Symbol | Typical | Maximum | Unit | | |
| Junction-to-Ambient ^a | t ≤ 10 s | - R _{thJA} | 15 | 18 | °C/W | | |
| Junction-to-Ambient* | Steady State | | 40 | 50 | | | |
| Junction-to-Case (Drain) | | R _{thJC} | 0.85 | 1.1 | | | |

- a. Surface mounted on 1" x 1" FR4 board.
- b. See SOA curve for voltage derating.



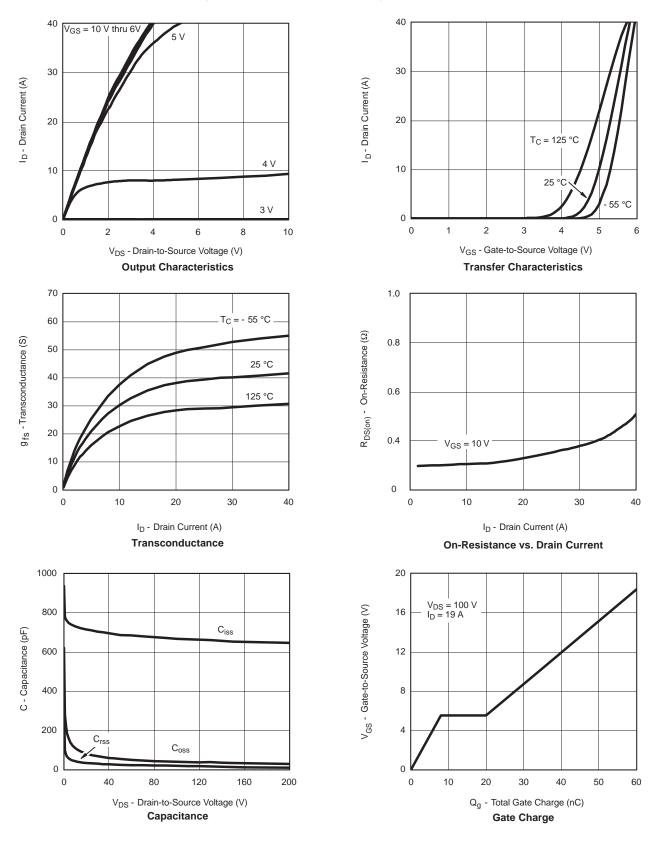
| Parameter | Symbol | Test Conditions | Min. | Typ.a | Max. | Unit | |
|---|---------------------|---|------|-------|-------|------|--|
| Static | • | , | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ 2 | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 2 | | 4 | V | |
| Gate-Body Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA | |
| | | V _{DS} = 200 V, V _{GS} = 0 V | | | 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 200 V, V _{GS} = 0 V, T _J = 125 °C | | | 50 | μΑ | |
| | | V _{DS} = 200 V, V _{GS} = 0 V, T _J = 175 °C | | | 250 | | |
| On-State Drain Current ^b | I _{D(on)} | $V_{DS} = 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 40 | | | Α | |
| | | V _{GS} = 10 V, I _D = 5 A | | 0.270 | | 0 | |
| Danie Course On Chata Banistan anh | R | V _{GS} = 10 V, I _D = 5 A, T _J = 125 °C | | 0.320 | | | |
| Drain-Source On-State Resistance ^b | R _{DS(on)} | V _{GS} = 10 V, I _D = 5 A, T _J = 175 °C | | 0.410 | | Ω | |
| | | $V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$ | | 0.310 | | | |
| Forward Transconductance ^b | 9 _{fs} | V _{DS} = 15 V, I _D = 19 A | | 35 | | S | |
| Dynamic ^a | | | | | | | |
| Input Capacitance | C _{iss} | | | 800 | | pF | |
| Output Capacitance | C _{oss} | $V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, F = 1 \text{ MHz}$ | | 110 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 80 | | | |
| Total Gate Charge ^c | Q_g | | | 30 | | | |
| Gate-Source Charge ^c | Q _{gs} | $V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 19 \text{ A}$ | | 8 | | nC | |
| Gate-Drain Charge ^c | Q_{gd} | | | 12 | | | |
| Gate Resistance | R _g | | 0.5 | | 2.9 | Ω | |
| Turn-On Delay Time ^c | t _{d(on)} | | | 15 | 25 | | |
| Rise Time ^c | t _r | $V_{DD} = 100 \text{ V}, R_{L} = 5.2 \Omega$ | | 50 | 75 | nc | |
| Turn-Off Delay Time ^c | t _{d(off)} | $I_D \cong 19 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 2.5 \Omega$ | | 30 | 45 | ns | |
| Fall Time ^c | t _f | | | 60 | 90 | | |
| Source-Drain Diode Ratings and Char | acteristics (7 | Γ _C = 25 °C) | | | | | |
| Pulsed Current | I _{SM} | | | | 40 | Α | |
| Diode Forward Voltage ^b | V_{SD} | I _F = 19 A, V _{GS} = 0 V | | 0.9 | 1.5 | V | |
| Source-Drain Reverse Recovery Time | t _{rr} | I _F = 19 A, dl/dt = 100 A/μs | | 180 | 250 | ns | |

- a. Guaranteed by design, not subject to production testing. b. Pulse test; pulse width $\leq 300~\mu s$, duty cycle $\leq 2~\%$. c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

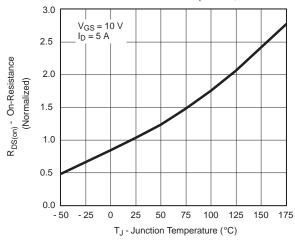


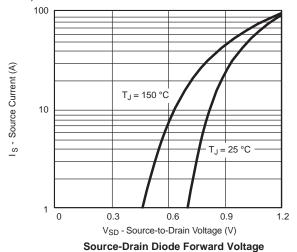
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





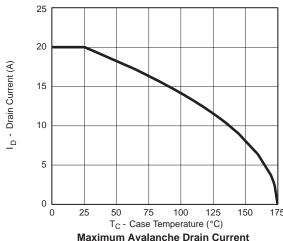
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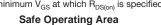


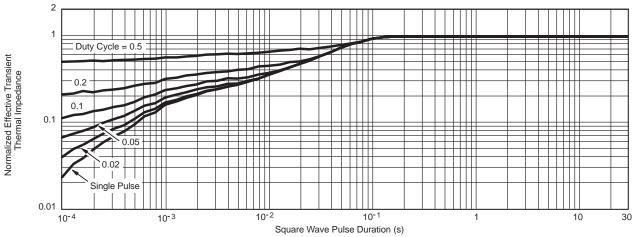
On-Resistance vs. Junction Temperature

THERMAL RATINGS



Maximum Avalanche Drain Current vs. Case Temperature

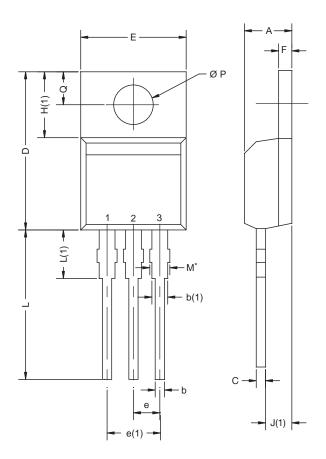




Normalized Thermal Transient Impedance, Junction-to-Case



TO-220AB



| | MILLIMETERS | | INC | HES | | |
|--|-------------|-------|-------|-------|--|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | | |
| Α | 4.25 | 4.65 | 0.167 | 0.183 | | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | | |
| С | 0.36 | 0.61 | 0.014 | 0.024 | | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | | |
| E | 10.04 | 10.51 | 0.395 | 0.414 | | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | | |
| ØР | 3.54 | 3.94 | 0.139 | 0.155 | | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | | |
| ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471 | | | | | | |

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion)
Heatsink hole for HVM



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